

**Search Notes**

Application/Control No.

10/527,757

Examiner

Tsz K. Chiu

Applicant(s)/Patent under  
Reexamination

SCHOTT ET AL.

Art Unit

2822

**SEARCHED**

Class	Subclass	Date	Examiner
257	421-427	2/4/2007	TC
257	108	2/4/2007	TC
257	206	2/4/2007	TC

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (text search see attach)	2/4/2007	TC